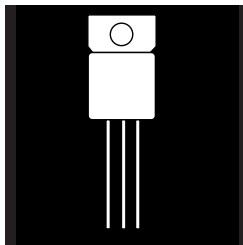


# INSULATED GATE BIPOLAR TRANSISTOR (IGBT) IN A HERMETIC TO-257AA PACKAGE



**500 Volt, 5 And 10 Amp, N-Channel IGBT  
In A Hermetic Metal Package**

## FEATURES

- Isolated Hermetic Metal Package
- High Input Impedance
- Low On-Voltage
- High Current Capability
- Fast Turn-Off
- Low Conductive Losses
- Available Screened to MIL-S-19500, TX, TXV And S Levels

## DESCRIPTION

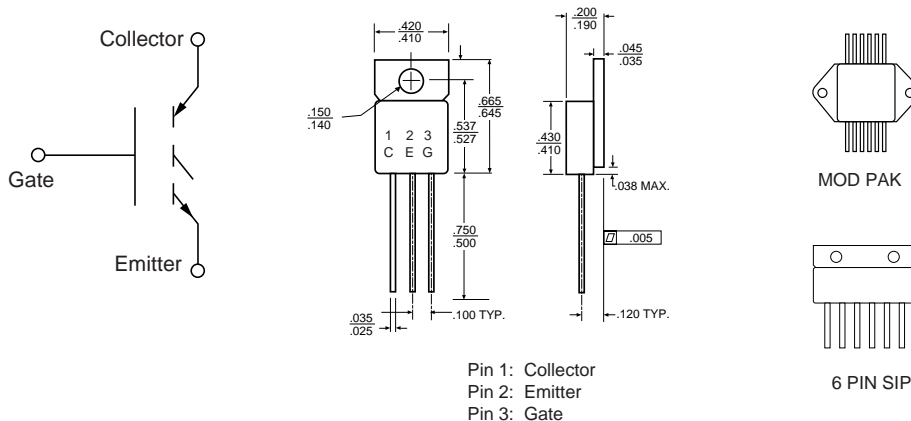
The IGBT power transistor features a high impedance insulated gate and a low on-resistance characteristic of bipolar transistors. These devices are ideally suited for motor drives, UPS converters, power supplies and resonant power converters.

## MAXIMUM RATINGS @ 25°C Unless Specified Otherwise

PART NUMBER	I <sub>c</sub> (Cont.) @ 90°C, A	V <sub>(BR)CES</sub> V	V <sub>CE(sat)</sub> (Typ.) V	T <sub>r</sub> (Typ.) ns	α <sub>jc</sub> °C/W	P <sub>D</sub> W	T <sub>J</sub> °C
OM6501ST	5	500	2.8	400	3.8	35	150
OM6502ST	10	500	2.8	400	3.0	42	150

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## SCHMATIC    MECHANICAL OUTLINE    PACKAGE OPTIONS



Note: IGBTs are also available in Z-Tab, dual and quad pak styles - Please call the factory for more information.

**PRELIMINARY DATA: OM6501ST**
**IGBT CHARACTERISTICS**

Parameter - OFF	Min.	Typ.	Max.	Units	Test Conditions
$V_{(BR)CES}$ Collector Emitter Breakdown Voltage	500			V	$V_{CE} = 0$ $I_C = 250 \mu A$
$I_{CES}$ Zero Gate Voltage Drain Current			0.25	mA	$V_{CE} = \text{Max. Rat.}, V_{GE} = 0$
			1.0	mA	$V_{CE} = 0.8 \text{ Max. Rat.}, V_{GE} = 0$ $T_C = 125^\circ C$
$I_{GES}$ Gate Emitter Leakage Current			$\pm 100$	nA	$V_{GE} = \pm 20 V$ $V_{CE} = 0 V$
<b>Parameter - ON</b>					
$V_{GE(th)}$ Gate Threshold Voltage	2.0		4.0	V	$V_{CE} = V_{GE}, I_C = 250 \mu A$
$V_{CE(sat)}$ Collector Emitter Saturation Voltage		3.0		V	$V_{GE} = 15 V, I_C = 5 A$ $T_C = 25^\circ C$
		2.8	3.0	V	$V_{GE} = 15 V, I_C = 5 A$ $T_C = 100^\circ C$
<b>Dynamic</b>					
$g_{fs}$ Forward Transductance		2.0		S	$V_{CE} = 20 V, I_C = 5 A$
$C_{ies}$ Input Capacitance		260		pF	$V_{GE} = 0$
$C_{oes}$ Output Capacitance		50		pF	$V_{CE} = 25 V$
$C_{res}$ Reverse Transfer Capacitance		20		pF	$f = 1 \text{ MHz}$
<b>Switching-Resistive Load</b>					
$T_{d(on)}$ Turn-On Time		37		nS	$V_{CC} = 400 V, I_C = 5 A$
$t_r$ Rise Time		150		nS	$V_{GE} = 15 V, R_g = 47$
<b>Switching-Inductive Load</b>					
$t_{(vot)}$ Off Voltage Rise Time		.35		$\mu S$	$V_{CEclamp} = 400 V, I_C = 5 A$
$t_f$ Fall Time		.81		$\mu S$	$V_{GE} = 15 V, R_g = 100$
$t_{cross}$ Cross-Over Time		1.2		$\mu S$	$L = 0.1 \text{ mH}, T_j = 100^\circ C$
$E_{off}$ Turn-Off Losses		.95		mJ	

**PRELIMINARY DATA: OM6502ST**
**IGBT CHARACTERISTICS**

Parameter - OFF	Min.	Typ.	Max.	Units	Test Conditions
$V_{(BR)CES}$ Collector Emitter Breakdown Voltage	500			V	$V_{CE} = 0$ $I_C = 250 \mu A$
$I_{CES}$ Zero Gate Voltage Drain Current			0.25	mA	$V_{CE} = \text{Max. Rat.}, V_{GE} = 0$
			1.0	mA	$V_{CE} = 0.8 \text{ Max. Rat.}, V_{GE} = 0$ $T_C = 125^\circ C$
$I_{GES}$ Gate Emitter Leakage Current			$\pm 100$	nA	$V_{GE} = \pm 20 V$ $V_{CE} = 0 V$
<b>Parameter - ON</b>					
$V_{GE(th)}$ Gate Threshold Voltage	2.0		4.0	V	$V_{CE} = V_{GE}, I_C = 250 \mu A$
$V_{CE(sat)}$ Collector Emitter Saturation Voltage		3.0		V	$V_{GE} = 15 V, I_C = 10 A$ $T_C = 25^\circ C$
		2.8	3.0	V	$V_{GE} = 15 V, I_C = 10 A$ $T_C = 100^\circ C$
<b>Dynamic</b>					
$g_{fs}$ Forward Transductance	2.5			S	$V_{CE} = 20 V, I_C = 10 A$
$C_{ies}$ Input Capacitance			950	pF	$V_{GE} = 0$
$C_{oes}$ Output Capacitance			140	pF	$V_{CE} = 25 V$
$C_{res}$ Reverse Transfer Capacitance			80	pF	$f = 1 \text{ MHz}$
<b>Switching-Resistive Load</b>					
$T_{d(on)}$ Turn-On Time			150	nS	$V_{CC} = 400 V, I_C = 10 A$
$t_r$ Rise Time			1000	nS	
$T_{d(off)}$ Turn-Off Delay Time			700	nS	$V_{GE} = 15 V, R_g = 100$
$t_f$ Fall Time			1500	nS	
<b>Switching-Inductive Load</b>					
$T_{d(off)}$ Turn-Off Delay Time			1.2	$\mu S$	$V_{CEclamp} = 350 V, I_C = 10 A$
$t_f$ Fall Time			1.5	$\mu S$	$V_{GE} = 15 V, R_g = 100$
$t_{cross}$ Cross-Over Time			2.0	$\mu S$	$L = 180 \mu H, T_j = 100^\circ C$
$E_{off}$ Turn-Off Losses			4.0	mJ	